

Features

- Common Latch-Enable Control
- Common Three-State Output Enable Control
- Buffered Inputs
- Three-State Outputs
- Bus Line Driving Capacity
- Typical Propagation Delay = 13ns at $V_{CC} = 5V$, $C_L = 15pF$, $T_A = 25^{\circ}C$ (Data to Output)
- Fanout (Over Temperature Range)
 - Standard Outputs 10 LSTTL Loads
 - Bus Driver Outputs 15 LSTTL Loads
- Wide Operating Temperature Range ... -55°C to 125°C
- Balanced Propagation Delay and Transition Times
- Significant Power Reduction Compared to LSTTL Logic ICs
- HC Types
 - 2V to 6V Operation
 - High Noise Immunity: $N_{IL} = 30\%$, $N_{IH} = 30\%$ of V_{CC} at $V_{CC} = 5V$
- HCT Types
 - 4.5V to 5.5V Operation
 - Direct LSTTL Input Logic Compatibility, $V_{IL} = 0.8V$ (Max), $V_{IH} = 2V$ (Min)
 - CMOS Input Compatibility, $I_I \leq 1\mu A$ at V_{OL} , V_{OH}

Description

The 'HC533, 'HCT533, 'HC563, and CD74HCT563 are high-speed Octal Transparent Latches manufactured with silicon gate CMOS technology. They possess the low power consumption of standard CMOS integrated circuits, as well as the ability to drive 15 LSTTL devices.

The outputs are transparent to the inputs when the latch enable (\overline{LE}) is high. When the latch enable (\overline{LE}) goes low the data is latched. The output enable (\overline{OE}) controls the three-state outputs. When the output enable (\overline{OE}) is high the outputs are in the high impedance state. The latch operation is independent of the state of the output enable.

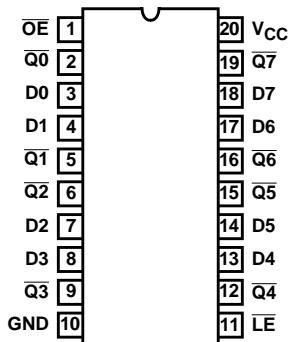
The 'HC533 and 'HCT533 are identical in function to the 'HC563 and CD74HCT563 but have different pinouts. The 'HC533 and 'HCT533 are similar to the 'HC373 and 'HCT373; the latter are non-inverting types.

Ordering Information

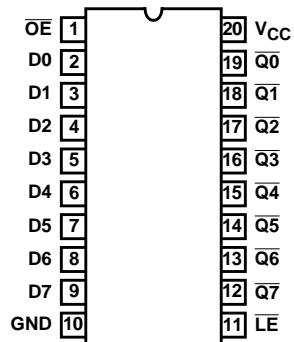
| PART NUMBER | TEMP. RANGE (°C) | PACKAGE |
|---------------|------------------|--------------|
| CD54HC533F3A | -55 to 125 | 20 Ld CERDIP |
| CD54HC563F3A | -55 to 125 | 20 Ld CERDIP |
| CD54HCT533F3A | -55 to 125 | 20 Ld CERDIP |
| CD74HC533E | -55 to 125 | 20 Ld PDIP |
| CD74HC563E | -55 to 125 | 20 Ld PDIP |
| CD74HC563M | -55 to 125 | 20 Ld SOIC |
| CD74HCT533E | -55 to 125 | 20 Ld PDIP |
| CD74HCT563E | -55 to 125 | 20 Ld PDIP |
| CD74HCT563M | -55 to 125 | 20 Ld SOIC |

Pinouts

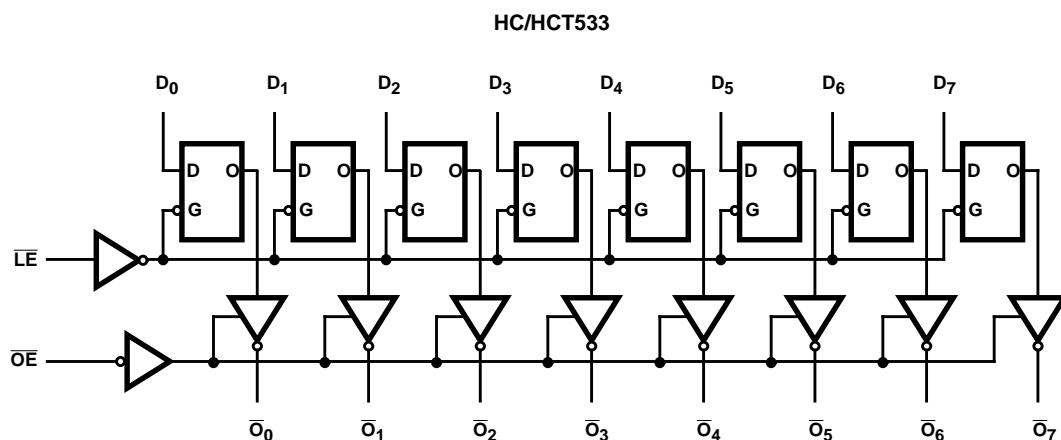
**CD54HC533, CD54HCT533
(CERDIP)
CD74HC533, CD74HCT533
(PDIP)
TOP VIEW**



**CD54HC563
(CERDIP)
CD74HC563, CD74HCT563
(PDIP, SOIC)
TOP VIEW**



Functional Block Diagram



TRUTH TABLE

| OUTPUT ENABLE | LATCH ENABLE | DATA | Q OUTPUT |
|---------------|--------------|------|----------|
| L | H | H | L |
| L | H | L | H |
| L | L | I | H |
| L | L | h | L |
| H | X | X | Z |

H = High Voltage Level, L = Low Voltage Level, X = Don't Care, Z = High Impedance State, I = Low voltage level one set-up time prior to the high to low latch enable transition, h = High voltage level one set-up time prior to the high to low latch enable transition.

CD54/74HC533, CD54/74HCT533, CD54/74HC563, CD74HCT563

Absolute Maximum Ratings

| | | |
|--|-------|-------------|
| DC Supply Voltage, V_{CC} | | -0.5V to 7V |
| DC Input Diode Current, I_{IK} For $V_I < -0.5V$ or $V_I > V_{CC} + 0.5V$ | | $\pm 20mA$ |
| DC Output Diode Current, I_{OK} For $V_O < -0.5V$ or $V_O > V_{CC} + 0.5V$ | | $\pm 20mA$ |
| DC Drain Current, per Output, I_O For $-0.5V < V_O < V_{CC} + 0.5V$ | | $\pm 35mA$ |
| DC Output Source or Sink Current per Output Pin, I_O For $V_O > -0.5V$ or $V_O < V_{CC} + 0.5V$ | | $\pm 25mA$ |
| DC V_{CC} or Ground Current, I_{CC} | | $\pm 50mA$ |

Thermal Information

| | |
|--|------------------------------------|
| Thermal Resistance (Typical, Note 1) | θ_{JA} ($^{\circ}C/W$) |
| E (PDIP) Package | 69 |
| M (SOIC) Package | 58 |
| Maximum Junction Temperature | 150 $^{\circ}C$ |
| Maximum Storage Temperature Range | -65 $^{\circ}C$ to 150 $^{\circ}C$ |
| Maximum Lead Temperature (Soldering 10s) | 300 $^{\circ}C$ |
| (SOIC - Lead Tips Only) | |

Operating Conditions

| | | |
|--|-------|------------------------------------|
| Temperature Range, T_A | | -55 $^{\circ}C$ to 125 $^{\circ}C$ |
| Supply Voltage Range, V_{CC} | | |
| HC Types | | 2V to 6V |
| HCT Types | | 4.5V to 5.5V |
| DC Input or Output Voltage, V_I, V_O | | 0V to V_{CC} |
| Input Rise and Fall Time | | |
| 2V | | 1000ns (Max) |
| 4.5V | | 500ns (Max) |
| 6V | | 400ns (Max) |

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

NOTE:

1. The package thermal impedance is calculated in accordance with JESD 51-7.

DC Electrical Specifications

| PARAMETER | SYMBOL | TEST CONDITIONS | | V_{CC} (V) | 25 $^{\circ}C$ | | | -40 $^{\circ}C$ TO 85 $^{\circ}C$ | | -55 $^{\circ}C$ TO 125 $^{\circ}C$ | | UNITS | | |
|--------------------------------------|----------|----------------------|------------|--------------|----------------|-----|-----------|-----------------------------------|---------|------------------------------------|---------|---------|--|--|
| | | V_I (V) | I_O (mA) | | MIN | TYP | MAX | MIN | MAX | MIN | MAX | | | |
| HC TYPES | | | | | | | | | | | | | | |
| High Level Input Voltage | V_{IH} | - | - | 2 | 1.5 | - | - | 1.5 | - | 1.5 | - | V | | |
| | | | | 4.5 | 3.15 | - | - | 3.15 | - | 3.15 | - | V | | |
| | | | | 6 | 4.2 | - | - | 4.2 | - | 4.2 | - | V | | |
| Low Level Input Voltage | V_{IL} | - | - | 2 | - | - | 0.5 | - | 0.5 | - | 0.5 | V | | |
| | | | | 4.5 | - | - | 1.35 | - | 1.35 | - | 1.35 | V | | |
| | | | | 6 | - | - | 1.8 | - | 1.8 | - | 1.8 | V | | |
| High Level Output Voltage CMOS Loads | V_{OH} | V_{IH} or V_{IL} | -0.02 | 2 | 1.9 | - | - | 1.9 | - | 1.9 | - | V | | |
| | | | -0.02 | 4.5 | 4.4 | - | - | 4.4 | - | 4.4 | - | V | | |
| High Level Output Voltage TTL Loads | | | -0.02 | 6 | 5.9 | - | - | 5.9 | - | 5.9 | - | V | | |
| | | | -6 | 4.5 | 3.98 | - | - | 3.84 | - | 3.7 | - | V | | |
| | | | -7.8 | 6 | 5.48 | - | - | 5.34 | - | 5.2 | - | V | | |
| Low Level Output Voltage CMOS Loads | V_{OL} | V_{IH} or V_{IL} | 0.02 | 2 | - | - | 0.1 | - | 0.1 | - | 0.1 | V | | |
| | | | 0.02 | 4.5 | - | - | 0.1 | - | 0.1 | - | 0.1 | V | | |
| | | | 0.02 | 6 | - | - | 0.1 | - | 0.1 | - | 0.1 | V | | |
| Low Level Output Voltage TTL Loads | | | 6 | 4.5 | - | - | 0.26 | - | 0.33 | - | 0.4 | V | | |
| | | | 7.8 | 6 | - | - | 0.26 | - | 0.33 | - | 0.4 | V | | |
| Input Leakage Current | I_I | V_{CC} or GND | - | 6 | - | - | ± 0.1 | - | ± 1 | - | ± 1 | μA | | |
| Quiescent Device Current | I_{CC} | V_{CC} or GND | 0 | 6 | - | - | 8 | - | 80 | - | 160 | μA | | |

CD54/74HC533, CD54/74HCT533, CD54/74HC563, CD74HCT563

DC Electrical Specifications (Continued)

| PARAMETER | SYMBOL | TEST CONDITIONS | | V _{CC} (V) | 25°C | | | -40°C TO 85°C | | -55°C TO 125°C | | UNITS |
|--|---------------------------|------------------------------------|---|---------------------|------|-----|------|---------------|------|----------------|-----|-------|
| | | V _I (V) | I _O (mA) | | MIN | TYP | MAX | MIN | MAX | MIN | MAX | |
| Three-State Leakage Current | - | V _{IL} or V _{IH} | V _O = V _{CC} or GND | 6 | - | - | ±0.5 | - | ±5 | - | ±10 | µA |
| HCT TYPES | | | | | | | | | | | | |
| High Level Input Voltage | V _{IH} | - | - | 4.5 to 5.5 | 2 | - | - | 2 | - | 2 | - | V |
| Low Level Input Voltage | V _{IL} | - | - | 4.5 to 5.5 | - | - | 0.8 | - | 0.8 | - | 0.8 | V |
| High Level Output Voltage CMOS Loads | V _{OH} | V _{IH} or V _{IL} | -0.02 | 4.5 | 4.4 | - | - | 4.4 | - | 4.4 | - | V |
| High Level Output Voltage TTL Loads | | | -6 | 4.5 | 3.98 | - | - | 3.84 | - | 3.7 | - | V |
| Low Level Output Voltage CMOS Loads | V _{OL} | V _{IH} or V _{IL} | 0.02 | 4.5 | - | - | 0.1 | - | 0.1 | - | 0.1 | V |
| Low Level Output Voltage TTL Loads | | | 6 | 4.5 | - | - | 0.26 | - | 0.33 | - | 0.4 | V |
| Input Leakage Current | I _I | V _{CC} to GND | - | 5.5 | - | - | ±0.1 | - | ±1 | - | ±1 | µA |
| Quiescent Device Current | I _{CC} | V _{CC} or GND | 0 | 5.5 | - | - | 8 | - | 80 | - | 160 | µA |
| Three-State Leakage Current | - | V _{IL} or V _{IH} | V _O = V _{CC} or GND | 5.5 | - | - | ±0.5 | - | ±5 | - | ±10 | µA |
| Additional Quiescent Device Current Per Input Pin: 1 Unit Load | ΔI _{CC} (Note 2) | V _{CC} -2.1 | - | 4.5 to 5.5 | - | 100 | 360 | - | 450 | - | 490 | µA |

NOTE:

2. For dual-supply systems theoretical worst case (V_I = 2.4V, V_{CC} = 5.5V) specification is 1.8mA.

HCT Input Loading Table

| INPUT | UNIT LOADS |
|---------|------------|
| D0 - D7 | 0.15 |
| LE | 0.30 |
| OE | 0.55 |

NOTE: Unit Load is ΔI_{CC} limit specified in DC Electrical Specifications table, e.g., 360µA max at 25°C.

CD54/74HC533, CD54/74HCT533, CD54/74HC563, CD74HCT563

Prerequisite For Switching Specifications

| PARAMETER | SYMBOL | TEST CONDITIONS | V _{CC} (V) | 25°C | | | -40°C TO 85°C | | -55°C TO 125°C | | UNITS |
|-----------------------------|-----------------|-----------------|---------------------|------|-----|-----|---------------|-----|----------------|-----|-------|
| | | | | MIN | TYP | MAX | MIN | MAX | MIN | MAX | |
| HC TYPES | | | | | | | | | | | |
| LE Pulse Width | t _W | - | 2 | 80 | - | - | 100 | - | 120 | - | ns |
| | | | 4.5 | 16 | - | - | 20 | - | 24 | - | ns |
| | | | 6 | 14 | - | - | 17 | - | 20 | - | ns |
| Set-up Time Data to LE | t _{SD} | - | 2 | 50 | - | - | 65 | - | 75 | - | ns |
| | | | 4.5 | 10 | - | - | 13 | - | 15 | - | ns |
| | | | 6 | 9 | - | - | 11 | - | 13 | - | ns |
| Hold Time, Data to LE (533) | t _H | - | 2 | 35 | - | - | 45 | - | 55 | - | ns |
| | | | 4.5 | 7 | - | - | 9 | - | 11 | - | ns |
| | | | 6 | 6 | - | - | 8 | - | 7 | - | ns |
| Hold Time, Data to LE (563) | t _H | - | 2 | 4 | - | - | 4 | - | 4 | - | ns |
| | | | 4.5 | 4 | - | - | 4 | - | 4 | - | ns |
| | | | 6 | 4 | - | - | 4 | - | 4 | - | ns |
| HCT TYPES | | | | | | | | | | | |
| LE Pulse Width | t _W | - | 4.5 | 16 | - | - | 20 | - | 24 | - | ns |
| Set-up Time Data to LE | t _{SD} | - | 4.5 | 10 | - | - | 13 | - | 15 | - | ns |
| Hold Time, Data to LE (533) | t _H | - | 4.5 | 8 | - | - | 10 | - | 12 | - | ns |
| Hold Time, Data to LE (563) | t _H | - | 4.5 | 5 | - | - | 5 | - | 5 | - | ns |

Switching Specifications Input t_r, t_f = 6ns

| PARAMETER | SYMBOL | TEST CONDITIONS | V _{CC} (V) | 25°C | | -40°C TO 85°C | | -55°C TO 125°C | | UNITS |
|---------------------------------------|-------------------------------------|-----------------------|---------------------|------|-----|---------------|-----|----------------|-----|-------|
| | | | | TYP | MAX | MAX | MAX | MAX | MAX | |
| HC TYPES | | | | | | | | | | |
| Propagation Delay, Data to Qn (HC533) | t _{PLH} , t _{PHL} | C _L = 50pF | 2 | - | 165 | 205 | 250 | - | - | ns |
| | | | 4.5 | - | 33 | 41 | 50 | - | - | ns |
| | | | 6 | - | 28 | 35 | 43 | - | - | ns |
| | | C _L = 15pF | 5 | 13 | - | - | - | - | - | ns |
| | | | 2 | - | 150 | 190 | 225 | - | - | ns |
| | | | 4.5 | - | 30 | 38 | 45 | - | - | ns |
| Propagation Delay, Data to Qn (HC563) | t _{PLH} , t _{PHL} | C _L = 50pF | 6 | - | 26 | 33 | 38 | - | - | ns |
| | | | 5 | 12 | - | - | - | - | - | ns |
| | | | 2 | - | 175 | 220 | 265 | - | - | ns |
| | | | 4.5 | - | 35 | 44 | 53 | - | - | ns |
| Propagation Delay, LE to Qn (HC533) | t _{PLH} , t _{PHL} | C _L = 50pF | 6 | - | 30 | 37 | 45 | - | - | ns |
| | | | 5 | 14 | - | - | - | - | - | ns |
| | | | 2 | - | 165 | 205 | 250 | - | - | ns |
| | | | 4.5 | - | 33 | 41 | 50 | - | - | ns |
| Propagation Delay, LE to Qn (HC563) | t _{PLH} , t _{PHL} | C _L = 50pF | 6 | - | 28 | 35 | 43 | - | - | ns |
| | | | 5 | 13 | - | - | - | - | - | ns |

CD54/74HC533, CD54/74HCT533, CD54/74HC563, CD74HCT563

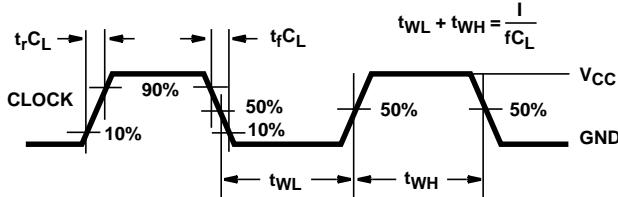
Switching Specifications Input $t_r, t_f = 6\text{ns}$ (Continued)

| PARAMETER | SYMBOL | TEST CONDITIONS | V_{CC} (V) | 25°C | | MAX | MAX | -55°C TO 125°C | UNITS |
|---|--------------------------------------|---------------------|--------------|------|-----|-----|-----|----------------|-------|
| | | | | TYP | MAX | | | | |
| Enable Times (HC533) | t_{PZH}, t_{PZL} | $C_L = 50\text{pF}$ | 2 | - | 150 | 190 | 225 | ns | |
| | | | 4.5 | - | 30 | 38 | 45 | ns | |
| | | | 6 | - | 26 | 33 | 38 | ns | |
| | | $C_L = 15\text{pF}$ | 5 | 12 | - | - | - | ns | |
| | | $C_L = 50\text{pF}$ | 2 | - | 150 | 190 | 225 | ns | |
| | | | 4.5 | - | 30 | 38 | 45 | ns | |
| | | | 6 | - | 26 | 33 | 38 | ns | |
| Disable Times (HC533) | t_{PHZ}, t_{PLZ} | $C_L = 50\text{pF}$ | 5 | 12 | - | - | - | ns | |
| | | | 4.5 | - | 30 | 38 | 45 | ns | |
| | | | 6 | - | 26 | 33 | 38 | ns | |
| | | $C_L = 15\text{pF}$ | 5 | 12 | - | - | - | ns | |
| | | $C_L = 50\text{pF}$ | 2 | - | 150 | 190 | 225 | ns | |
| | | | 4.5 | - | 30 | 38 | 45 | ns | |
| | | | 6 | - | 26 | 33 | 38 | ns | |
| Enable and Disable Times (HC563) | $t_{PZH}, t_{PZL}, t_{PHZ}, t_{PLZ}$ | $C_L = 50\text{pF}$ | 5 | 12 | - | - | - | ns | |
| | | | 4.5 | - | 30 | 38 | 45 | ns | |
| | | | 6 | - | 26 | 33 | 38 | ns | |
| | | $C_L = 15\text{pF}$ | 5 | 12 | - | - | - | ns | |
| Input Capacitance | C_I | - | - | - | 10 | 10 | 10 | pF | |
| Three-State Output Capacitance | C_O | - | - | - | 20 | 20 | 20 | pF | |
| Power Dissipation Capacitance (Notes 3, 4) | C_{PD} | - | 5 | 42 | - | - | - | pF | |
| HCT TYPES | | | | | | | | | |
| Propagation Delay, Data to Qn (HC/HCT533) | t_{PLH}, t_{PHL} | $C_L = 50\text{pF}$ | 4.5 | - | 34 | 43 | 51 | ns | |
| | | $C_L = 15\text{pF}$ | 5 | 14 | - | - | - | ns | |
| Propagation Delay, Data to Qn (HC/HCT563) | t_{PLH}, t_{PHL} | $C_L = 50\text{pF}$ | 4.5 | - | 30 | 38 | 45 | ns | |
| | | $C_L = 15\text{pF}$ | 5 | 12 | - | - | - | ns | |
| Propagation Delay, $\bar{L}E$ to Qn (HC/HCT533) | t_{PLH}, t_{PHL} | $C_L = 50\text{pF}$ | 4.5 | - | 38 | 48 | 57 | ns | |
| | | $C_L = 15\text{pF}$ | 5 | 16 | - | - | - | ns | |
| Propagation Delay, $\bar{L}E$ to Qn (HC/HCT563) | t_{PZL}, t_{PZH} | $C_L = 50\text{pF}$ | 4.5 | - | 35 | 44 | 53 | ns | |
| | | $C_L = 15\text{pF}$ | 5 | 14 | - | - | - | ns | |
| Enable Times (HC/HCT533) | t_{PLZ}, t_{PZH} | $C_L = 50\text{pF}$ | 4.5 | - | 35 | 44 | 53 | ns | |
| | | $C_L = 15\text{pF}$ | 5 | 14 | - | - | - | ns | |
| Disable Times (HC/HCT533) | t_{TLH}, t_{THL} | $C_L = 50\text{pF}$ | 4.5 | - | 30 | 38 | 45 | ns | |
| | | $C_L = 15\text{pF}$ | 5 | 12 | - | - | - | ns | |
| Enable and Disable Times (HC/HCT563) | $t_{PZH}, t_{PZL}, t_{PHZ}, t_{PLZ}$ | $C_L = 50\text{pF}$ | 4.5 | - | 35 | 44 | 53 | ns | |
| | | $C_L = 15\text{pF}$ | 5 | 14 | - | - | - | ns | |
| Input Capacitance | C_I | - | - | - | 10 | 10 | 10 | pF | |
| Power Dissipation Capacitance (Notes 3, 4) | C_{PD} | - | 5 | 42 | - | - | - | pF | |

NOTES:

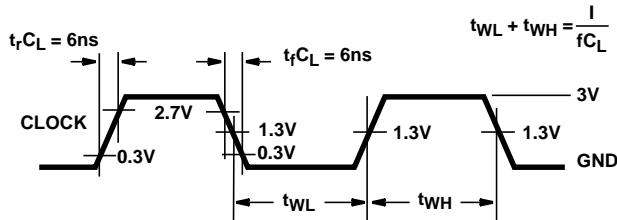
3. C_{PD} is used to determine the no-load dynamic power consumption, per latch.
4. P_D (total power per latch) = $C_{PD} V_{CC}^2 f_i + \sum C_L V_{CC}^2 f_o$ where f_i = Input Frequency, f_o = Output Frequency, C_L = Output Load Capacitance, V_{CC} = Supply Voltage.

Test Circuits and Waveforms



NOTE: Outputs should be switching from 10% V_{CC} to 90% V_{CC} in accordance with device truth table. For f_{MAX} , input duty cycle = 50%.

FIGURE 1. HC CLOCK PULSE RISE AND FALL TIMES AND PULSE WIDTH



NOTE: Outputs should be switching from 10% V_{CC} to 90% V_{CC} in accordance with device truth table. For f_{MAX} , input duty cycle = 50%.

FIGURE 2. HCT CLOCK PULSE RISE AND FALL TIMES AND PULSE WIDTH

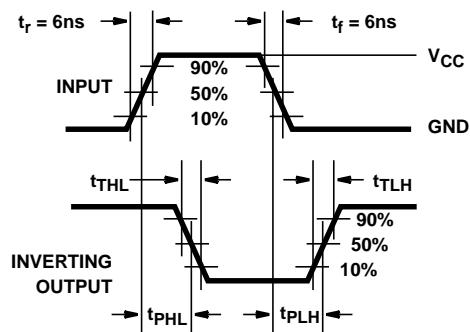


FIGURE 3. HC TRANSITION TIMES AND PROPAGATION DELAY TIMES, COMBINATION LOGIC

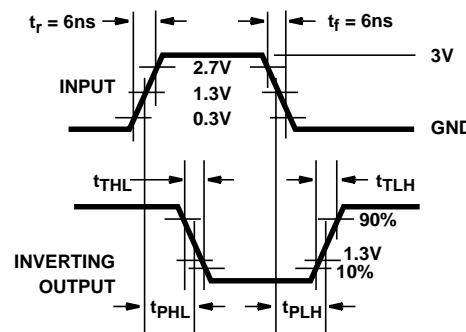


FIGURE 4. HCT TRANSITION TIMES AND PROPAGATION DELAY TIMES, COMBINATION LOGIC

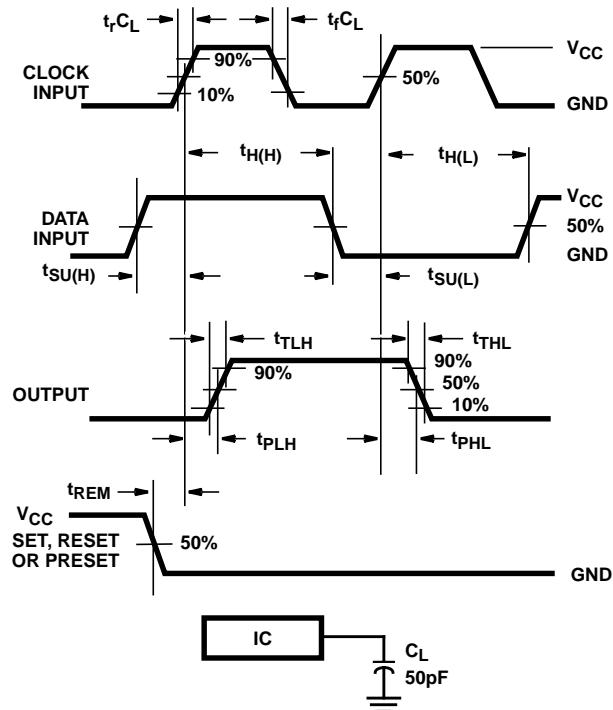


FIGURE 5. HC SETUP TIMES, HOLD TIMES, REMOVAL TIME, AND PROPAGATION DELAY TIMES FOR EDGE TRIGGERED SEQUENTIAL LOGIC CIRCUITS

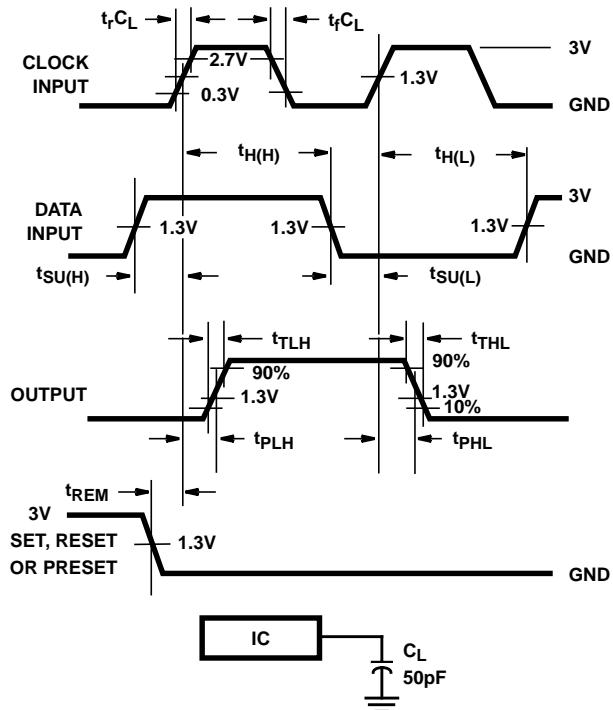


FIGURE 6. HCT SETUP TIMES, HOLD TIMES, REMOVAL TIME, AND PROPAGATION DELAY TIMES FOR EDGE TRIGGERED SEQUENTIAL LOGIC CIRCUITS

Test Circuits and Waveforms (Continued)

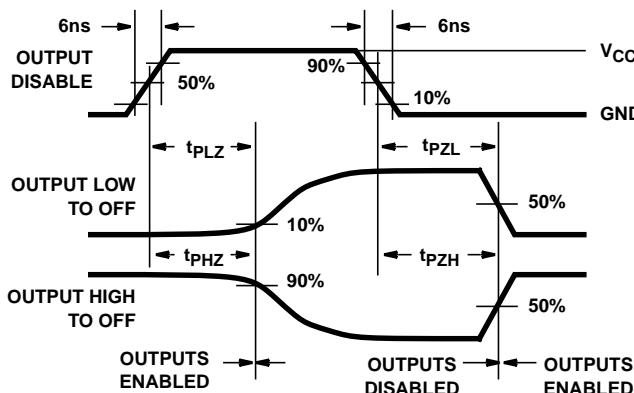


FIGURE 7. HC THREE-STATE PROPAGATION DELAY WAVEFORM

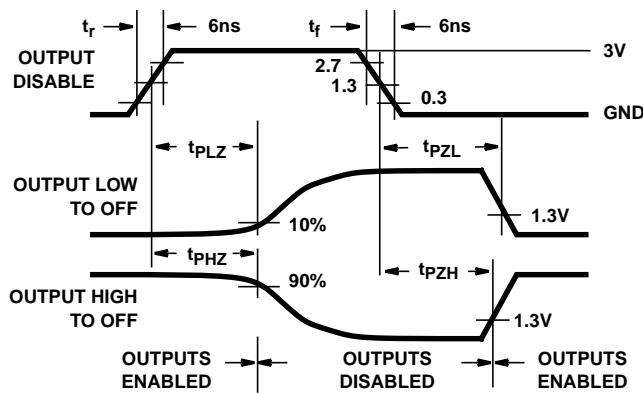
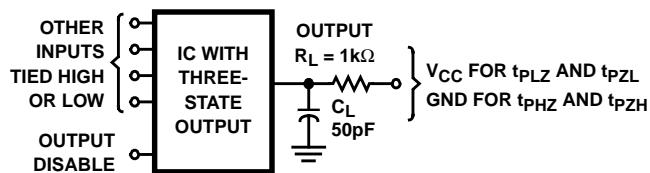


FIGURE 8. HCT THREE-STATE PROPAGATION DELAY WAVEFORM



NOTE: Open drain waveforms t_{PLZ} and t_{PZL} are the same as those for three-state shown on the left. The test circuit is Output $R_L = 1k\Omega$ to V_{CC} , $C_L = 50pF$.

FIGURE 9. HC AND HCT THREE-STATE PROPAGATION DELAY TEST CIRCUIT

PACKAGING INFORMATION

| Orderable part number | Status (1) | Material type (2) | Package Pins | Package qty Carrier | RoHS (3) | Lead finish/ Ball material (4) | MSL rating/ Peak reflow (5) | Op temp (°C) | Part marking (6) |
|-----------------------|---------------|----------------------|----------------|-----------------------|-------------|--------------------------------------|-----------------------------------|--------------|--------------------------------|
| 5962-8606201RA | Active | Production | CDIP (J) 20 | 20 TUBE | No | SNPB | N/A for Pkg Type | -55 to 125 | 5962-8606201RA CD54HC563F3A |
| 5962-8681301RA | Active | Production | CDIP (J) 20 | 20 TUBE | No | SNPB | N/A for Pkg Type | -55 to 125 | 5962-8681301RA CD54HC533F3A |
| CD54HC533F3A | Active | Production | CDIP (J) 20 | 20 TUBE | No | SNPB | N/A for Pkg Type | -55 to 125 | 5962-8681301RA CD54HC533F3A |
| CD54HC533F3A.A | Active | Production | CDIP (J) 20 | 20 TUBE | No | SNPB | N/A for Pkg Type | -55 to 125 | 5962-8681301RA CD54HC533F3A |
| CD54HC563F3A | Active | Production | CDIP (J) 20 | 20 TUBE | No | SNPB | N/A for Pkg Type | -55 to 125 | 5962-8606201RA CD54HC563F3A |
| CD54HC563F3A.A | Active | Production | CDIP (J) 20 | 20 TUBE | No | SNPB | N/A for Pkg Type | -55 to 125 | 5962-8606201RA CD54HC563F3A |
| CD54HCT533F3A | Active | Production | CDIP (J) 20 | 20 TUBE | No | SNPB | N/A for Pkg Type | -55 to 125 | CD54HCT533F3A |
| CD54HCT533F3A.A | Active | Production | CDIP (J) 20 | 20 TUBE | No | SNPB | N/A for Pkg Type | -55 to 125 | CD54HCT533F3A |
| CD74HC533E | Active | Production | PDIP (N) 20 | 20 TUBE | Yes | NIPDAU | N/A for Pkg Type | -55 to 125 | CD74HC533E |
| CD74HC533E.A | Active | Production | PDIP (N) 20 | 20 TUBE | Yes | NIPDAU | N/A for Pkg Type | -55 to 125 | CD74HC533E |
| CD74HC563E | Active | Production | PDIP (N) 20 | 20 TUBE | Yes | NIPDAU | N/A for Pkg Type | -55 to 125 | CD74HC563E |
| CD74HC563E.A | Active | Production | PDIP (N) 20 | 20 TUBE | Yes | NIPDAU | N/A for Pkg Type | -55 to 125 | CD74HC563E |
| CD74HCT533E | Active | Production | PDIP (N) 20 | 20 TUBE | Yes | NIPDAU | N/A for Pkg Type | -55 to 125 | CD74HCT533E |
| CD74HCT533E.A | Active | Production | PDIP (N) 20 | 20 TUBE | Yes | NIPDAU | N/A for Pkg Type | -55 to 125 | CD74HCT533E |
| CD74HCT563E | Active | Production | PDIP (N) 20 | 20 TUBE | Yes | NIPDAU | N/A for Pkg Type | -55 to 125 | CD74HCT563E |
| CD74HCT563E.A | Active | Production | PDIP (N) 20 | 20 TUBE | Yes | NIPDAU | N/A for Pkg Type | -55 to 125 | CD74HCT563E |
| CD74HCT563M | Active | Production | SOIC (DW) 20 | 25 TUBE | Yes | NIPDAU | Level-1-260C-UNLIM | -55 to 125 | HCT563M |
| CD74HCT563M.A | Active | Production | SOIC (DW) 20 | 25 TUBE | Yes | NIPDAU | Level-1-260C-UNLIM | -55 to 125 | HCT563M |

⁽¹⁾ **Status:** For more details on status, see our [product life cycle](#).

⁽²⁾ **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

⁽⁴⁾ **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

⁽⁶⁾ **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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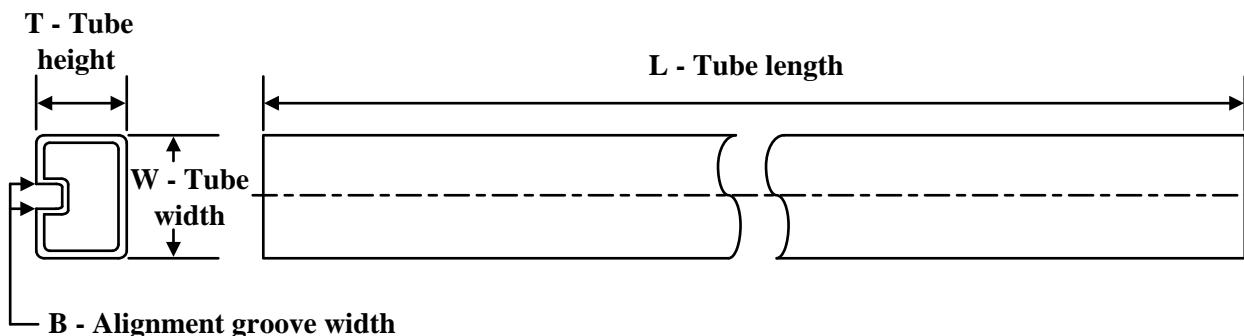
In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

OTHER QUALIFIED VERSIONS OF CD54HC533, CD54HC563, CD54HCT533, CD74HC533, CD74HC563, CD74HCT533 :

- Catalog : [CD74HC533](#), [CD74HC563](#), [CD74HCT533](#)
- Military : [CD54HC533](#), [CD54HC563](#), [CD54HCT533](#)

NOTE: Qualified Version Definitions:

- Catalog - TI's standard catalog product
- Military - QML certified for Military and Defense Applications

TUBE


*All dimensions are nominal

| Device | Package Name | Package Type | Pins | SPQ | L (mm) | W (mm) | T (μ m) | B (mm) |
|---------------|--------------|--------------|------|-----|--------|--------|--------------|--------|
| CD74HC533E | N | PDIP | 20 | 20 | 506 | 13.97 | 11230 | 4.32 |
| CD74HC533E.A | N | PDIP | 20 | 20 | 506 | 13.97 | 11230 | 4.32 |
| CD74HC563E | N | PDIP | 20 | 20 | 506 | 13.97 | 11230 | 4.32 |
| CD74HC563E.A | N | PDIP | 20 | 20 | 506 | 13.97 | 11230 | 4.32 |
| CD74HCT533E | N | PDIP | 20 | 20 | 506 | 13.97 | 11230 | 4.32 |
| CD74HCT533E.A | N | PDIP | 20 | 20 | 506 | 13.97 | 11230 | 4.32 |
| CD74HCT563E | N | PDIP | 20 | 20 | 506 | 13.97 | 11230 | 4.32 |
| CD74HCT563E.A | N | PDIP | 20 | 20 | 506 | 13.97 | 11230 | 4.32 |
| CD74HCT563M | DW | SOIC | 20 | 25 | 507 | 12.83 | 5080 | 6.6 |
| CD74HCT563M.A | DW | SOIC | 20 | 25 | 507 | 12.83 | 5080 | 6.6 |

J (R-GDIP-T**)

14 LEADS SHOWN

CERAMIC DUAL IN-LINE PACKAGE



| PINS ** DIM | 14 | 16 | 18 | 20 |
|----------------|------------------------|------------------------|------------------------|------------------------|
| A | 0.300 (7,62) BSC | 0.300 (7,62) BSC | 0.300 (7,62) BSC | 0.300 (7,62) BSC |
| B MAX | 0.785 (19,94) | .840 (21,34) | 0.960 (24,38) | 1.060 (26,92) |
| B MIN | — | — | — | — |
| C MAX | 0.300 (7,62) | 0.300 (7,62) | 0.310 (7,87) | 0.300 (7,62) |
| C MIN | 0.245 (6,22) | 0.245 (6,22) | 0.220 (5,59) | 0.245 (6,22) |



4040083/F 03/03

NOTES: A. All linear dimensions are in inches (millimeters).
B. This drawing is subject to change without notice.
C. This package is hermetically sealed with a ceramic lid using glass frit.
D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

N (R-PDIP-T**)

16 PINS SHOWN

PLASTIC DUAL-IN-LINE PACKAGE



NOTES: A. All linear dimensions are in inches (millimeters).
 B. This drawing is subject to change without notice.

△ Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).

△ The 20 pin end lead shoulder width is a vendor option, either half or full width.

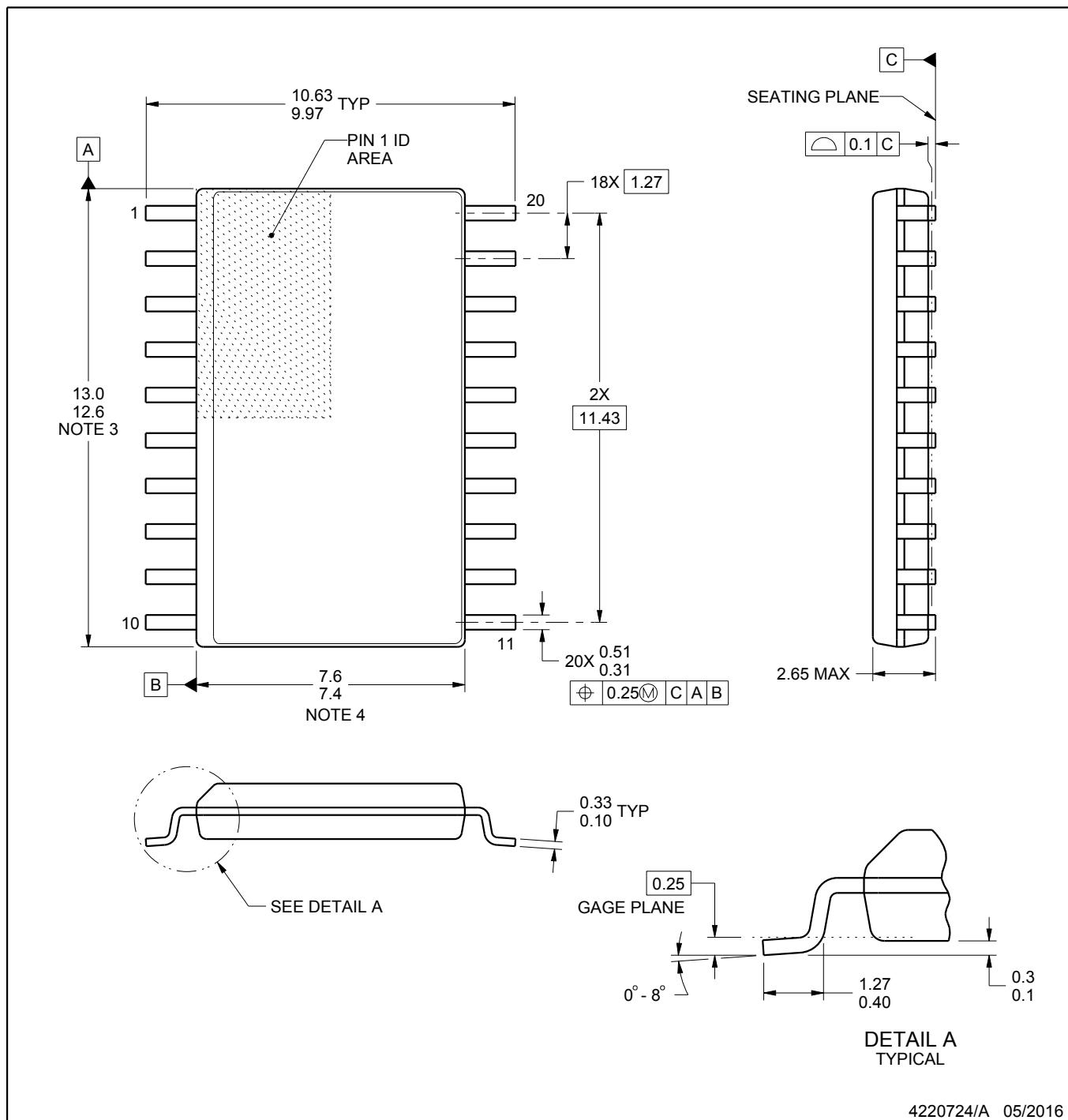


PACKAGE OUTLINE

DW0020A

SOIC - 2.65 mm max height

SOIC



NOTES:

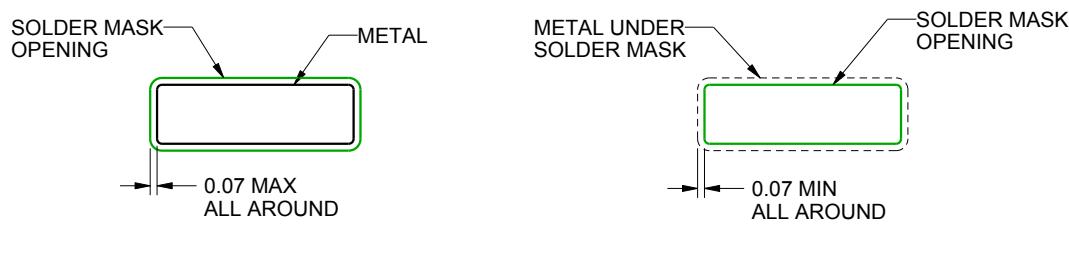
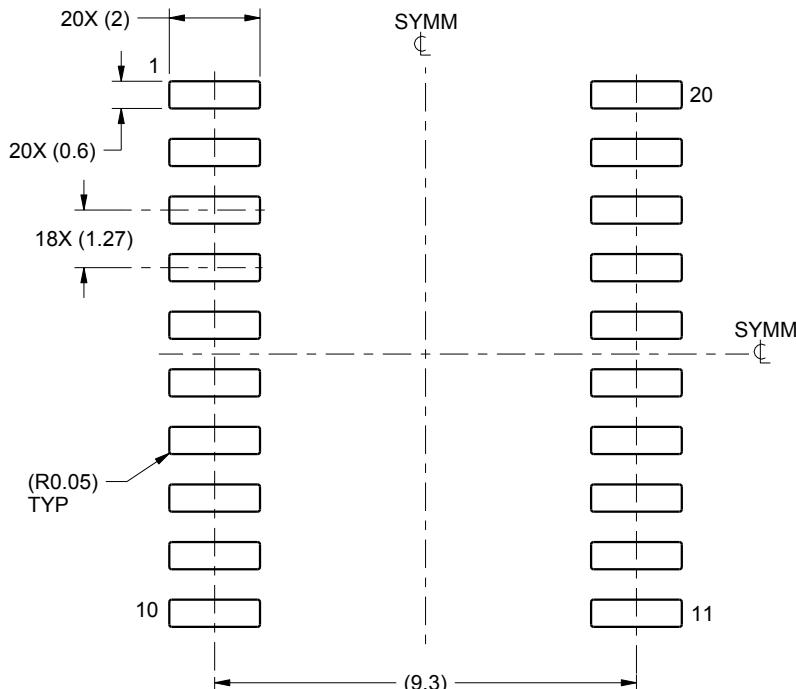
1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.43 mm per side.
5. Reference JEDEC registration MS-013.

EXAMPLE BOARD LAYOUT

DW0020A

SOIC - 2.65 mm max height

SOIC



SOLDER MASK DETAILS

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NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

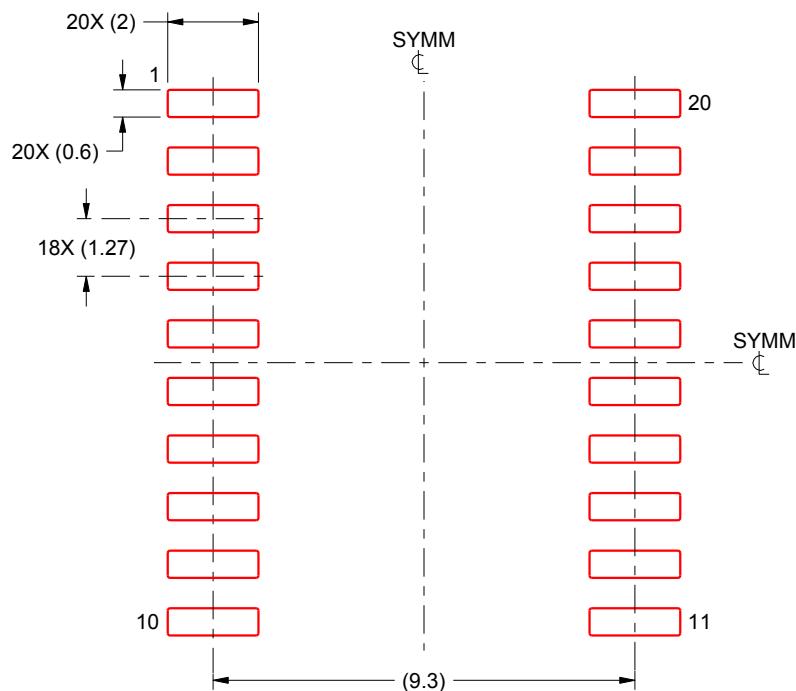
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN

DW0020A

SOIC - 2.65 mm max height

SOIC



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE:6X

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NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

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